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APPLICATION NO	). F	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/710,451		07/12/2004	Nikila KRISHNAMOORTHY	TI-36271 4450	
23494	7590	04/20/2006		NER	
		ENTS INCORPO	TABONE JR, JOHN J		
	P O BOX 655474, M/S 3999 DALLAS, TX 75265			ART UNIT	PAPER NUMBER
•				2138	
				DATE MAILED: 04/20/2006	

Please find below and/or attached an Office communication concerning this application or proceeding.

	[ A 19 49 A						
	Application No.	Applicant(s)					
	10/710,451	KRISHNAMOORTHY ET AL.					
Office Action Summary	Examiner	Art Unit					
	John J. Tabone, Jr.	2138					
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address					
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA  - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period w  - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tin rill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	N. nely filed the mailing date of this communication. ED (35 U.S.C. § 133).					
Status							
1)⊠ Responsive to communication(s) filed on <u>14 Ja</u>	nuary 2005						
· <del>-</del>	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in accordance with the practice under E							
Disposition of Claims							
4)⊠ Claim(s) <u>1-14</u> is/are pending in the application.							
	4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.							
6) Claim(s) <u>1-9,11,13 and 14</u> is/are rejected.							
7) Claim(s) 10 and 12 is/are objected to.							
8) Claim(s) are subject to restriction and/or	r election requirement.						
Application Papers	•						
9) The specification is objected to by the Examine	r						
10)⊠ The drawing(s) filed on <u>14 January 2005</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).							
11) The oath or declaration is objected to by the Ex							
Priority under 35 U.S.C. § 119							
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).							
a) ☐ All b) ☐ Some * c) ☐ None of:							
3. Copies of the certified copies of the prior	rity documents have been receive	ed in this National Stage					
application from the International Bureau	ı (PCT Rule 17.2(a)).	•					
* See the attached detailed Office action for a list	of the certified copies not receive	∍d.					
		•					
Attachment(s)							
1) Notice of References Cited (PTO-892)	4) Interview Summary	/ (PTO-413)					
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail D	eate					
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	5)  Notice of Informal F 6)  Other:	Patent Application (PTO-152)					

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#### **DETAILED ACTION**

1. Claims 1-14 have been examined.

## Claim Objections

- 2. Claims 2 and 8 are objected to because of the following informalities: The preliminary amendment of 11/16/2004 improperly amended claim 2 to depend on itself and claim 8 to depend on claim 2. This appears to the Examiner to be in error. For purpose of examination the Examiner will read claim 2 as being dependent on claim 1 and claim 8 as being dependent on claim 7. Appropriate correction is required.
- 3. Claims 10 and 12 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form <u>including all of the limitations</u> of the base claim and any intervening claims.

# Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

4. Claim 12 is rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

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#### Clam 12:

This claim recites the limitations "said derived clock signal" on line 3 and "said original control signal" on lines 5 and 7. There is insufficient antecedent basis for this limitation in the claim. For reason for examination the Examiner will read "said derived clock signal" as "said derived control signal" and "said original control signal" as "said first control signal". Correction is required in response to this Office Action.

Further, claim 12 would be allowable if rewritten to overcome the rejection(s) under 35 U.S.C. 112, 2nd paragraph, set forth in this Office action and to include all of the limitations of the base claim and any intervening claims.

## Claim Rejections - 35 USC § 103 ·

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. Claims 1-9, 11, 13 and 14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Park et al. (US-6742151B2), hereinafter Park, in view of Mangum et al. (US-6744285B2), hereinafter Mangum.

#### Claims 1 and 7:

Park teaches <u>an integrated circuit</u> (integrated circuit 1, Fig. 1) designed for testing of <u>a first module</u> (core 30, Fig. 1), wherein said first module is to be integrated into said integrated circuit (integrated circuit 1, Fig. 1). Park also teaches <u>a second</u>

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module (user defined logic (UDL) 40, Fig. 1) provided with a capability of being tested in each of a plurality of characteristics of a first control signal (Scan Clock, SCK-IN, Fig. 1). (Col. 5, I. 28 to col. 7, I. 10).

Park does not explicitly teach "a test logic being programmable to generate a derived control signal having a desired characteristic, wherein said derived control signal is generated from said first control signal, and wherein said derived control signal of said desired characteristic is provided as a control signal to said second module and said second module is tested with said desired characteristic of said first control signal by programming said test logic". However, Park does teach a test logic (a scan signal converting circuit 100, Fig. 1 and 2) to generate a derived control signal (SCK, Fig. 1 and 2), wherein said derived control signal (SCK, Fig. 1 and 2) is generated from said first control signal (Scan Clock, SCK-IN, Fig. 1). Park also teaches the first scan signal converting circuit 110 includes first delay cell 111. The delayed clock signals from the first delay 111 is then input to the UDL 40 as the output scan clock signal SCK. (Fig. 2, col. 6, Il. 22-23, 45-61).

Mangum teaches in an analogous art "test logic (phase-alignment system) being programmable to generate a derived control signal" in that the phase-alignment system comprises a user interface 60 that provides a user with a mechanism by which the phase-alignment circuits 40 and 50 can be controlled. Each of the phase-alignment circuits 40 and 50 comprises delay elements that have known delay times. The phases of clocks A and B can be varied by adjusting the number of delay elements in the paths of clocks A and B or by adjusting the number of delay elements in the path of the

reference clock. The placement of the delay elements in the clock paths is controlled by the user through the user interface. Mangum also teaches, in reference to Fig. 4, the number of delay elements that are placed in the clock paths is controlled (**test logic being programmable**) by the select lines 74, "SELECT\_A\_DELAY", and 75, "SELECT\_REF\_DELAY", which are controlled (i.e. programmed) by the user via the user interface 60. The select lines 74 and 75 are each multi-bit lines that are received by multiplexers A 76 and B 77. The number of delay elements that are connected in series with the clock lines <u>depends on the bit values</u> that are delivered to the multiplexers 76 and 77. (Col. 3, I. 49 to col. 4, I. 18). It would have been obvious to one of ordinary skill in the art at the time the invention was made to replace Park's first delay cell 111 with Mangum's phase-alignment circuit 40. The artisan would be motivated to do so because it would enable Park control the phases or edges of the control signals

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#### Claims 2 and 8:

Park teaches "said desired characteristic is determined to test said path at a same speed as in a functional mode" in that in Fig. 4 Park illustrates the generated test clocks SCK and CK is the same frequency as the external clocks SCK-IN and CK-IN, thus testing the first module and the second module at the same speed as in functional mode.

based on a programmed bit pattern from Mangum's user interface.

#### Claims 3 and 9:

Park in view of Mangum teaches "said <u>first control signal</u> (Scan Clock, SCK-IN, Fig. 1) comprises a clock signal". Park in view of Mangum does not explicitly teach said

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test logic can be programmed to generate said derived control signal as an inverted signal of said clock signal". However, Park in view of Mangum does teach phase-alignment circuit 40 can be programmed to vary the amount of delay on a particular clock signal in effect changing the phase. It would have been obvious to one of ordinary skill in the art at the time the invention was made that the <u>derived control signal</u> (SCK, Fig. 1 and 2) can be delayed such that it becomes 180 degrees out of phase with the <u>first control signal</u> (Scan Clock, SCK-IN, Fig. 1). The artisan would be motivated to do so because this programming would effectively invert the <u>derived control signal</u> (SCK, Fig. 1 and 2).

#### Claims 4 and 11:

Park in view of Mangum does not explicitly teach "said first control signal comprises a scan enable signal and wherein said programmable field can be set to generate said derived control signal as rising edge triggered or falling edge triggered scan enable signal". However, Park in view of Mangum does teach, as per the rejection of claims 3 and 9 above, the derived control signal (SCK, Fig. 1 and 2) can be delayed such that it becomes 180 degrees out of phase with the first control signal (Scan Clock, SCK-IN, Fig. 1), effectively inverting the derived control signal (SCK, Fig. 1 and 2). It would have been obvious to one of ordinary skill in the art at the time the invention was made that Mangum's phase-alignment circuit 40 can be programmed to vary the amount of delay on any particular signal (i.e. clock, scan enable) in effect changing the phase. The artisan would be motivated to do so because this would enable Park in view

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of Mangum to introduce enough delay in the <u>derived control signal</u> (i.e. scan enable) such that it becomes a <u>rising edge</u> triggered or <u>falling edge</u> triggered signal.

## Claims 5 and 13:

Park in view of Mangum teaches "said test logic (a scan signal converting circuit 100, Fig. 1 and 2) comprises a register (Mangum's MUX A and B, Fig. 4) which can be programmed".

## Claims 6 and 14:

Park teaches said first module comprises a core module (core 30, Fig. 1) provided by a third party not designing said integrated circuit, and said second module is designed by a designer designing said integrated circuit (user defined logic (UDL) 40, Fig. 1).

# Allowable Subject Matter

Claims 10 ands 12 are allowed.

The following is an Examiner's Statement of Reasons for Allowance:

The present invention relates to testing of integrated circuits, and more specifically to a method and apparatus for testing of modules operating with different characteristics of control signals using scan based techniques.

The claimed invention as set forth in claim 10 recites features such as: test logic that comprises a bit indicating whether said derived control signal is to be generated as a positive clock signal or a negative clock signal and an XOR logic gate receiving said bit and said clock signal and generating said derived control signal.

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The prior arts of record teach a scan signal converting circuit 100 (i.e Park in view of Mangum) that can be programmed via user interface 60 to vary the delays as to change the phase of clock signals used for different modules (core 30, UDL, Fig. 1 of Park); Park et al. (US-6742151B2) and Mangum et al. (US-6744285B2) are examples of such prior arts.

The prior arts of record, however, fail to teach, singly or in combination, the limitations of claim 10, namely the bit indicating whether said derived control signal is to be generated as a positive clock signal or a negative clock signal and the XOR logic gate that receives the indicating bit and the clock signal to generate the derived control signal. As such, modification of the prior art of record to include the claimed indicating bit and XOR logic gate can only be motivated by hindsight reasoning, or by changing the intended use and function of the prior art themselves. Therefore, it is not clear that one of ordinary skill in the art at the time of the invention would have made the necessary modifications to the prior art of record to encompass the indicating bit and XOR logic gate set forth in the present application. Moreover, none of the prior arts of record, taken either alone or in combination, anticipate nor render obvious the indicating bit and XOR logic gate as set forth in claim 10.

Note: The <u>bolded/italics/underlined</u> words in claim 12 below are the anticipated corrections as per the 35 U.S.C. 112, 2nd paragraph, rejection above.

The claimed invention as set forth in claim 12 recites features such as: test logic that comprises <u>a bit indicating</u> whether said derived <u>control</u> signal is to be generated as said rising edge triggered or said falling edge triggered scan enable signal, <u>a flip-flop</u>

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coupled to receive said <u>first</u> control signal and being clocked on an inverted clock signal and <u>a multiplexor</u> selecting either the output of said flip-flop or said <u>first</u> control signal under the control of said bit.

The prior arts of record teach a scan signal converting circuit 100 (i.e Park in view of Mangum) that can be programmed via user interface 60 to vary the delays as to change the phase of clock signals used for different modules (core 30, UDL, Fig. 1 of Park); Park et al. (US-6742151B2) and Mangum et al. (US-6744285B2) are examples of such prior arts.

The prior arts of record, however, fail to teach, singly or in combination, the limitations of claim 12, namely the indication bit, the flip-flop and multiplexor. As such, modification of the prior art of record to include the claimed indication bit, the flip-flop and multiplexor can only be motivated by hindsight reasoning, or by changing the intended use and function of the prior art themselves. Therefore, it is not clear that one of ordinary skill in the art at the time of the invention would have made the necessary modifications to the prior art of record to encompass the indication bit, the flip-flop and multiplexor set forth in the present application. Moreover, none of the prior arts of record, taken either alone or in combination, anticipate nor render obvious the indication bit, the flip-flop and multiplexor as set forth in claim 12.

Hence, claims 10 and 12 are allowable over the prior arts of record.

The Examiner agrees with the Applicant's arguments with regard to this feature in view of the arts of record; therefore, the Examiner favors the allowance of claims 10 and 12. Any comments considered necessary by applicant must be submitted no later

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than the payment of the Issue Fee and, to avoid processing delays, should preferably accompany the Issue Fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

#### Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to John J. Tabone, Jr. whose telephone number is (571) 272-3827. The examiner can normally be reached on M-F.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Albert DeCady can be reached on (571) 272-3819. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

The J. Labere, J. 4/13/06 John J. Tabone, Jr.

Examiner Art Unit 2138 .

PRIMARY EXAMINER